FDS3680

SEMICONDUCTOR IM

100V N-Channel PowerTrench[®] MOSFET

General Description

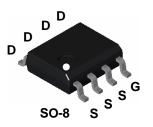
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

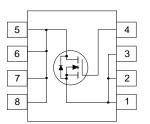
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 5.2 A, 100 V. $R_{DS(ON)} = 46 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 51 \text{ m}\Omega @ V_{GS} = 6 \text{ V}$
- Low gate charge
- Fast switching speed
- High performance trench technology for extremely low R_{DS(ON)}
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		100	V
V _{GSS}	Gate-Source Voltage		±20	V
ID	Drain Current – Continuous	(Note 1a)	5.2	A
	- Pulsed		50	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1.0	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W	

Package Marking and Ordering Information

Device Marking Device		Reel Size Tape width		Quantity	
FDS3680	FDS3680	13"	12mm	2500 units	

© 2000 Fairchild Semiconductor Corporation

FDS3680

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Drain-So	burce Avalanche Ratings (Note	2)				
W _{DSS}	Single Pulse Drain-Source	$V_{DD} = 50 \text{ V}, \qquad I_D = 5.2 \text{ A}$			245	mJ
AR	Avalanche Energy Maximum Drain-Source Avalanche				5.2	A
Off Cha	Current					I
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	100	1		V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		101		mV/°C
	Zero Gate Voltage Drain Current	$V_{DS} = 80 V$, $V_{GS} = 0 V$			10	μA
	Gate–Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
	Gate–Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
	acteristics (Note 2)					<u>.</u>
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	2.4	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-6.5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_D = 5.2 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ I}_D = 5.2 \text{ A}, \text{ T}_J = 125^{\circ}\text{C}$ $V_{CC} = 6 \text{ V}, \text{ I}_D = 4.5 \text{ A}$		32 61 34	46 92 51	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 6 \text{ V}, I_D = 4.5 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	25			Α
g _{FS}	Forward Transconductance	$V_{DS} = 5 V$, $I_D = 5.2 A$		25		S
Dvnami	c Characteristics	•				
C _{iss}	Input Capacitance	$V_{DS} = 50 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1735		pF
Coss	Output Capacitance	f = 1.0 MHz		176		pF
Crss	Reverse Transfer Capacitance	-		53		pF
Switchir	ng Characteristics (Note 2)	•				
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$		14	25	ns
t _r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 10 \Omega$		8.5	17	ns
t _{d(off)}	Turn–Off Delay Time			63	94	ns
t _f	Turn–Off Fall Time			21	34	ns
Qg	Total Gate Charge			38	53	nC
Q _{gs}	Gate-Source Charge			8.1		nC
Q _{gd}	Gate-Drain Charge	-		9.2		nC
Drain–S	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain–Source				2.1	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 2.1 A$ (Note 2)		0.73	1.2	V

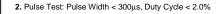


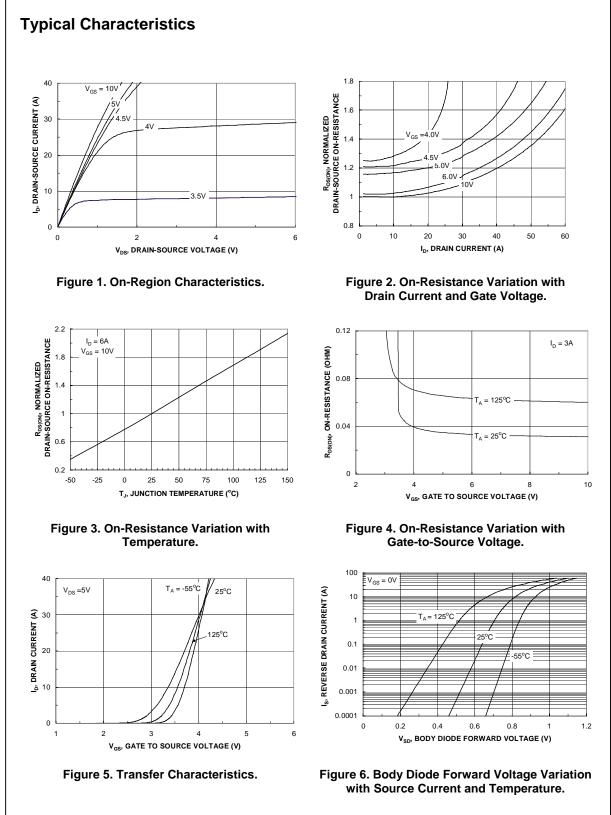




b) 105°C/W when mounted on a 0.04 in² pad of 2 oz copper c) 125°C/W when mounted on a minimum pad.

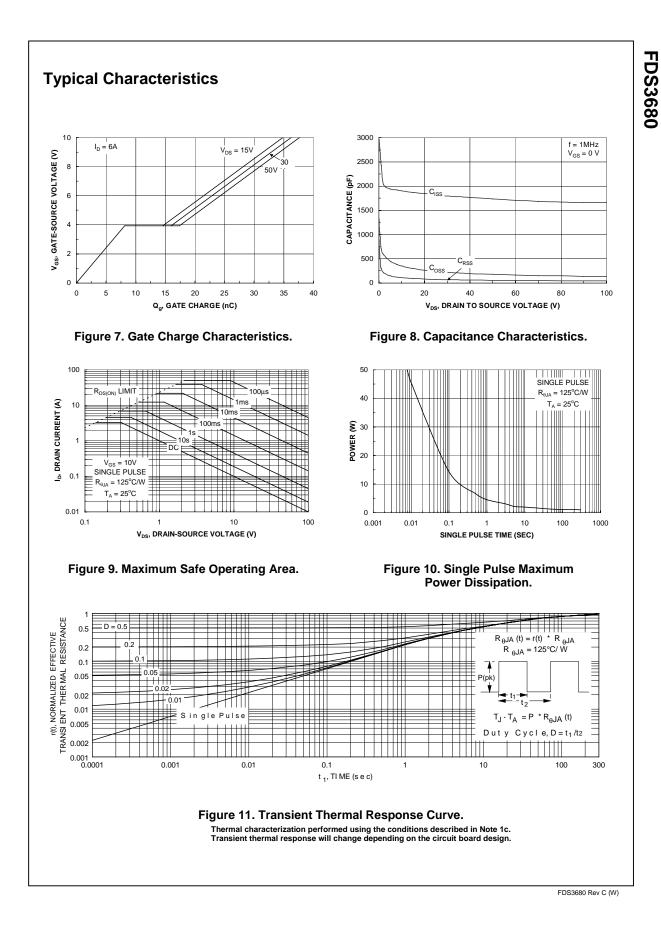
FDS3680 Rev C (W)





FDS3680

FDS3680 Rev C (W)



TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™ Bottomless™ CoolFET™ CROSSVOLT™ DOME™ E²CMOS[™] EnSigna™ FACT™ FACT Quiet Series[™] FAST[®]

FASTr™ GlobalOptoisolator™ GTO™ HiSeC™ **ISOPLANAR™** MICROWIRE™ OPTOLOGIC™ **OPTOPLANAR™** PACMAN™ POP™

PowerTrench[®] QFET™ QS™ QT Optoelectronics[™] Quiet Series[™] SILENT SWITCHER® SMART START™ SuperSOT[™]-3 SuperSOT[™]-6 SuperSOT[™]-8

SyncFET™ TinyLogic™ UHC™ VCX™

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
	1	Rev G